Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	_
09/770,112	MOUTIN, JEAN-MICHEL	
Examiner	Art Unit	_
Allen Wong	2621	

	SEARCHED				
Class	Subclass	Date	Examiner		
375	240	1/4/2007	AW		
375	240.01	1/4/2007	AW		
375	240.12	1/4/2007	AW		
375	240.24	1/4/2007	AW		
375	240.28	1/4/2007	AW		
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INT	INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
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